







TMUX1574

SCDS391B-OCTOBER 2018-REVISED SEPT 2019

TMUX1574 Low-Capacitance, 2:1 (SPDT) 4-Channel, Powered-Off Protected Switch with 1.8 V Logic

1 Features

- Wide supply range: 1.5 V to 5.5 V
- Low on-capacitance: 7.5 pF
- Low on-resistance: 2 Ω
- High bandwidth: 2 GHz
- -40°C to +125°C operating temperature
- 1.8 V Logic Compatible
- Supports Input Voltage Beyond Supply
- Integrated Pull Down Resistor on Logic Pins
- Bidirectional Signal Path
- Fail-Safe Logic
- Powered-off Protection up to 3.6 V Signals
 - Pinout compatible to SN74CBTLV3257

2 Applications

- Servers
- Data center switches & routers
- Wireless infrastructure
- PC & notebooks
- Building automation
- Grid infrastructure
- ePOS
- Appliances
- Flash memory sharing
- JTAG multiplexing
- SPI multiplexing

3 Description

The TMUX1574 is a complementary metal-oxide semiconductor (CMOS) switch. The TMUX1574 offers 2:1 SPDT switch configuration with 4-channels. Wide operating supply of 1.5 V to 5.5 V allows for use in a broad array of applications from servers and communication equipment to industrial applications. The device supports bidirectional analog and digital signals on the source (SxA, SxB) and drain (Dx) pins and can pass signals above supply up to $V_{DD} \times 2$, with a maximum input/output voltage of 5.5 V.

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Powered-off Protection up to 3.6 V on the signal path of the TMUX1574 provides isolation when the supply voltage is removed ($V_{DD} = 0$ V). Without this protection feature, switches can back-power the supply rail through an internal ESD diode and cause potential damage to the system.

Fail-Safe Logic circuitry allows voltages on the logic control pins to be applied before the supply pin, protecting the device from potential damage. All control inputs have 1.8 V logic compatible thresholds, ensuring both TTL and CMOS logic compatibility when operating in the valid supply voltage range. Integrated pull down resistor on the logic pins removes external components to reduce system size and cost.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)		
TMUX1574	TSSOP (16)	5.00 mm × 4.40 mm		
	UQFN (16)	2.60 mm x 1.80 mm		
	SOT-23-THIN (16)	4.20 mm x 2.00 mm		

(1) For all available packages, see the package option addendum at the end of the data sheet.

Block Diagram

TMUX1574 S1A D1 S1B -0 S2A D2 S2B -0 S3A 0 D3 S3B c S4A 0 D4 S4B -0 LOGIC CONTROL* SFL FN *Internal 6MΩ Pull-Down on Logic Pins

Application Example



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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision A (December 2018) to Revision B	Page
Added the SOT-23-THIN (DYY) package to the data sheet	
Added thermal information for DYY package.	
Changes from Original (October 2018) to Revision A	Page

•	Changed the document status From: Advanced Information To: Production data	1



5 Pin Configuration and Functions



RSV Package 16-Pin UQFN **Top View** S1A VDD SEL 1 1 Г L 10 15 4 $\tilde{\mathbf{c}}$ S1B S4A 1 12 D1 S4B 11 2 S2A D4 3 10 S2B S3A 14 9 ß ശ I ٦ ⁻1 1 1 1 I Not to scale GND S3B 22 ß

NSTRUMENTS

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	Pin Functions						
	PIN						
NAME	TSSOP / SOT-23-THIN	UQFN	TYPE ⁽¹⁾	DESCRIPTION ⁽²⁾			
SEL	1	15	I	Select pin: controls state of switches according to Table 1. Internal 6 M Ω pull-down to GND.			
S1A	2	16	I/O	Source pin 1A. Can be an input or output.			
S1B	3	1	I/O	Source pin 1B. Can be an input or output.			
D1	4	2	I/O	Drain pin 1. Can be an input or output.			
S2A	5	3	I/O	Source pin 2A. Can be an input or output.			
S2B	6	4	I/O	Source pin 2B. Can be an input or output.			
D2	7	5	I/O	Drain pin 2. Can be an input or output.			
GND	8	6	Р	Ground (0 V) reference			
D3	9	7	I/O	Drain pin 3. Can be an input or output.			
S3B	10	8	I/O	Source pin 3B. Can be an input or output.			
S3A	11	9	I/O	Source pin 3A. Can be an input or output.			
D4	12	10	I/O	Drain pin 4. Can be an input or output.			
S4B	13	11	I/O	Source pin 4B. Can be an input or output.			
S4A	14	12	I/O	Source pin 4A. Can be an input or output.			
ĒN	15	13	I	Active low enable: When this pin is high, all switches are turned off. When this pin is low, SEL pin controls the signal path selection. Internal 6 M Ω pull-down to GND.			
VDD	16	14	Ρ	Positive power supply. This pin is the most positive power-supply potential. For reliable operation, connect a decoupling capacitor ranging from 0.1 μF to 10 μF between V_{DD} and GND.			

(1) (2)

I = input, O = output, I/O = input and output, P = power Refer to Device Functional Modes for what to do with unused pins.

6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) $^{(1)(2)(3)}$

		MIN	MAX	UNIT
V _{DD}	Supply voltage	-0.5	6	V
$V_{\text{SEL}} \text{ or } V_{\text{EN}}$	Logic control input pin voltage (SEL or EN)	-0.5	6	V
I _{SEL} or I _{EN}	Logic control input pin current (SEL or EN)	-30	30	mA
V_S or V_D	Source or drain pin voltage	-0.5	6	V
I _S or I _{D (CONT)}	Source and drain pin continuous current: (SxA, SxB, Dx)	-25	25	mA
T _{stg}	Storage temperature	-65	150	°C
TJ	Junction temperature		150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum.

(3) All voltages are with respect to ground, unless otherwise specified.

6.2 ESD Ratings

			VALUE	UNIT
	Electrostatio discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
V _(ESD)	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±750	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

		MIN	MAX	UNIT
V _{DD}	Supply voltage	1.5	5.5	V
V_{S} or V_{D}	Signal path input/output voltage (source or drain pin), $V_{DD} \ge 1.5 V^{(1)}$	0	V _{DD} x 2	V
$V_{S_{off}}$ or $V_{D_{off}}$	Signal path input/output voltage (source or drain pin), V_{DD} < 1.5 $V^{(2)}$	0	3.6	V
V_{SEL} or V_{EN}	Logic control input voltage (EN, SEL)	0	5.5	V
T _A	Ambient temperature	-40	125	°C

(1) Device input/output can operate up to V_{DD} x 2, with a maximum input/output voltage of 5.5 V.

(2) $V_{S off}$ and $V_{D off}$ refers to the voltage at the source or drain pins when supply is less than 1.5 V.

6.4 Thermal Information

		DEVICE	DEVICE	DEVICE	
	THERMAL METRIC ⁽¹⁾	PW (TSSOP)	DYY (SOT-23)	RSV (UQFN)	UNIT
		16 PINS	16 PINS	16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	117.4	123.0	129.2	°C/W
R _{0JC(top)}	Junction-to-case (top) thermal resistance	47.9	70.5	69.7	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	63.7	50.4	58.7	°C/W
Ψ_{JT}	Junction-to-top characterization parameter	6.9	5.0	3.6	°C/W
Ψ_{JB}	Junction-to-board characterization parameter	63.1	50.3	56.8	°C/W
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	°C/W

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.

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6.5 Electrical Characteristics

 $\label{eq:VDD} \begin{array}{l} V_{DD} = 1.5 \mbox{ V to 5.5 V, GND} = 0 \mbox{V}, \mbox{ } T_A = -40^{\circ} \mbox{C to +125^{\circ} \mbox{C}} \\ \hline \mbox{Typical values are at } V_{DD} = 3.3 \mbox{ V, } \mbox{ } T_A = 25^{\circ} \mbox{C}, \mbox{ (unless otherwise noted)} \end{array}$

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
POWER S	UPPLY					
V _{DD}	Power supply voltage		1.5		5.5	V
I _{DD}	Active supply current	$\label{eq:VSEL} \begin{array}{l} V_{SEL} = 0 \ V, \ 1.4 V \ or \ V_{DD} \\ V_{S} = 0 \ V \ to \ 5.5 \ V \end{array}$		40	68	μA
I _{DD_STANDB} Y	Supply current when disabled	$V_{EN} = 1.4V \text{ or } V_{DD}$ $V_{S} = 0 V \text{ to } 5.5 V$		7.5	15	μA
DC CHAR	ACTERISTICS					
R _{ON}	On-resistance	$\label{eq:V_s} \begin{array}{l} V_s = 0 \; V \; to \; V_{DD}^{\star} 2 \\ V_{S(max)} = 5.5 \; V \\ I_{SD} = 8 \; mA \\ \text{Refer to ON-State Resistance Figure} \end{array}$		2	4.5	Ω
ΔR_{ON}	On-resistance match between channels	$\label{eq:V_S} \begin{array}{l} V_S = V_{DD} \\ I_{SD} = 8 \mbox{ mA} \\ \mbox{Refer to ON-State Resistance Figure} \end{array}$		0.07	0.28	Ω
R _{ON (FLAT)}	On-resistance flatness	$\label{eq:Vs} \begin{array}{l} V_{S}=0 \; V \; to \; V_{DD} \\ I_{SD}=8 \; mA \\ \text{Refer to ON-State Resistance Figure} \end{array}$		1	1.8	Ω
I _{POFF}	Powered-off I/O pin leakage current	$ \begin{array}{l} V_{DD}=\ 0\ V \\ V_S=\ 0\ V\ to\ 3\ V \\ V_D=\ 0\ V \\ T_A=25^\circ C \\ Refer to \ Ipoff \ Leakage \ Figure \\ \end{array} $	-10	0.01	10	nA
I _{POFF}	Powered-off I/O pin leakage current	$ \begin{array}{l} V_{DD}=~0~V\\ V_S=~0~V~to~3.6~V\\ V_D=~0~V\\ \mbox{Refer to Ipoff Leakage Figure} \end{array} $	-2	0.01	2	μA
I _{S(OFF)} I _{D(OFF)}	OFF leakage current	$\label{eq:switch_Off} \begin{split} & \text{Switch_Off} \\ & \text{V}_{\text{D}} = 0.8^* \text{V}_{\text{DD}} / 0.2^* \text{V}_{\text{DD}} \\ & \text{V}_{\text{S}} = 0.2^* \text{V}_{\text{DD}} / 0.8^* \text{V}_{\text{DD}} \\ & \text{Refer to Off Leakage Figure} \end{split}$	-100	0.03	100	nA
I _{D(ON)} I _{S(ON)}	ON leakage current	$ Switch On \\ V_D = 0.8^*V_{DD} / 0.2^*V_{DD}, S pins floating \\ or \\ V_S = 0.8^*V_{DD} / 0.2^*V_{DD}, D pins floating \\ Refer to On Leakage Figure $	-50	0.01	50	nA
LOGIC INF	PUTS				·	
VIH	Input logic high		1.2		5.5	V
V _{IL}	Input logic low		0		0.45	V
I _{IH}	Input high leakage current	V_{SEL} = 1.8 V, V_{DD}		1	±2	μA
I _{IL}	Input low leakage current	V _{SEL} = 0 V		0.2	±2	μA
R _{PD}	Internal pull-down resistor on logic pins			6		MΩ
CI	Logic input capacitance	$V_{SEL} = 0 V$, 1.8 V or V_{DD} f = 1 MHz		3		pF



6.6 Dynamic Characteristics

 $\label{eq:VDD} \begin{array}{l} V_{DD} = 1.5 \ V \ to \ 5.5 \ V, \ GND = 0V, \ T_A = -40^\circ C \ to \ +125^\circ C \\ \hline Typical \ values \ are \ at \ V_{DD} = 3.3 \ V, \ T_A = 25^\circ C, \ (unless \ otherwise \ noted) \end{array}$

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
C _{OFF}	Source and drain off capacitance	$V_S = 2.5 V$ $V_{SEL}= 0 V$ f = 1 MHz Refer to Capacitance Figure	Switch OFF		3.5	6	pF
C _{ON}	Source and drain on capacitance	$V_{S} = 2.5 V$ $V_{SEL} = 0 V$ f = 1 MHz Refer to Capacitance Figure	Switch ON		7.5	12	pF
Q _C	Charge Injection	$\label{eq:VS} \begin{array}{l} V_S = V_{DD}/2 \\ R_S = 0 \; \Omega, \; C_L = 1 \; nF \\ \text{Refer to Charge Injection Figure} \end{array}$	Switch ON		3.5		рС
_	Off instanting	$R_L = 50 \Omega$ f = 100 kHz Refer to Off Isolation Figure	Switch OFF		-90		dB
O _{ISO}	Off isolation	$R_L = 50 \ \Omega$ f = 1 MHz Refer to Off Isolation Figure	Switch OFF		-75		dB
X _{TALK}	Channel to Channel crosstalk	$R_L = 50 \ \Omega$ f = 100 kHz Refer to Crosstalk Figure	Switch ON		-90		dB
BW	Bandwidth	$R_L = 50 \Omega$ Refer to Bandwidth Figure	Switch ON		2		GHz
I _{LOSS}	Insertion loss	$R_L = 50 \Omega$ f = 1 MHz Refer to Bandwidth Figure	Switch ON		-0.12		dB

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6.7 Timing Requirements

 $\label{eq:VDD} \begin{array}{l} V_{DD} = 1.5 \ V \ to \ 5.5 \ V, \ GND = 0V, \ T_A = -40^\circ C \ to \ +125^\circ C \\ \hline Typical \ values \ are \ at \ V_{DD} = 3.3 \ V, \ T_A = 25^\circ C, \ (unless \ otherwise \ noted) \end{array}$

PARAMETER		TEST CONDITIONS	MIN	NOM	MAX	UNIT
t _{TRAN}	Transition time from control input	$\begin{split} V_{DD} &= 2.5 \text{ V to } 5.5 \text{ V} \\ V_S &= V_{DD} \\ R_L &= 200 \ \Omega, \ C_L &= 15 \text{pF} \\ \text{Refer to Transition Timing Figure} \end{split}$		160	350	ns
t _{TRAN}	Transition time from control input	$\begin{split} V_{DD} &< 2.5 \text{ V} \\ V_S &= V_{DD} \\ R_L &= 200 \ \Omega, \ C_L &= 15 \text{pF} \\ \text{Refer to Transition Timing Figure} \end{split}$		180	580	ns
t _{ON(EN)}	Device turn on time from enable pin			12	35	μs
t _{OFF(EN)}	Device turn off time from enable pin	$ \begin{array}{l} V_{S} = V_{DD} \\ R_{L} = 200 \ \Omega, \ C_{L} = 15 pF \\ \text{Refer to Ton(EN) \& Toff(EN) Figure} \end{array} $		50	95	ns
t _{on(VDD)}	Device turn on time (V _{DD} to output)	$V_{S} = 3.6 V$ $V_{DD} \text{ rise time} = 1 \text{us}$ $R_{L} = 200 \Omega, C_{L} = 15 \text{pF}$ Refer to Ton(vdd) & Toff(vdd) Figure		20	60	μs
t _{OFF(VDD)}	Device turn off time (V_{DD} to output)	$ \begin{array}{l} V_{\rm S} = 3.6 \ V \\ V_{\rm DD} \ \mbox{fall time} = 1 \mbox{us} \\ R_{\rm L} = 200 \ \Omega, \ C_{\rm L} = 15 \mbox{pF} \\ \ \mbox{Refer to } \ \mbox{Ton(vdd)} \ \mbox{K Toff(vdd) Figure} \end{array} $		1.2	2.7	μs
t _{open (BBM)}	Break before make time	V_{S} = 1 V R_{L} = 200 Ω , C_{L} = 15pF Refer to Topen(BBM) Figure	0.5			ns
t _{SK(P)}	Inter - channel skew - QFN (RSV)	Refer to Tsk Figure		5		ps
t _{SK(P)}	Inter - channel skew - DYY (SOT-23)	Refer to Tsk Figure		10		ps
t _{SK(P)}	Inter - channel skew - TSSOP (PW)	Refer to Tsk Figure		18		ps
t _{PD}	Propagation delay - QFN (RSV)	Refer to Tpd Figure		50		ps
t _{PD}	Propagation delay - DYY (SOT-23)	Refer to Tpd Figure		70		ps
t _{PD}	Propagation delay - TSSOP (PW)	Refer to Tpd Figure		95		ps

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6.8 Typical Characteristics

at $T_A = 25^{\circ}C$, $V_{DD} = 5 V$ (unless otherwise noted)



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Typical Characteristics (continued)





Typical Characteristics (continued)





Typical Characteristics (continued)





6.8.1 Eye Diagrams



7

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ISD

V_{DD}

V_{DD}

C

D1

S1A

S1B

-0

IS (OFF)

А

On-Resistance 7.1

Parameter Measurement Information

The on-resistance of a device is the ohmic resistance between the source (Sx) and drain (Dx) pins of the device. The on-resistance varies with input voltage and supply voltage. The symbol R_{ON} is used to denote on-resistance. The measurement setup used to measure R_{ON} is shown in Figure 27. Voltage (V) and current (I_{SD}) are measured using this setup, and R_{ON} is computed as shown below with $R_{ON} = V / I_{SD}$:



Dx

7.2 Off-Leakage Current

Source leakage current is defined as the leakage current flowing into or out of the source pin when the switch is off. This current is denoted by the symbol I_{S (OFF)}.

Drain leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is off. This current is denoted by the symbol I_{D (OFF)}.

The setup used to measure both off-leakage currents is shown in Figure 28.

D1

ID (OFF)

V_{DD}

V_{DD}

S1A o

S1B

Sx



Figure 28. Off-Leakage Measurement Setup

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7.3 On-Leakage Current

Source on-leakage current is defined as the leakage current flowing into or out of the source pin when the switch is on. This current is denoted by the symbol $I_{S (ON)}$.

Drain on-leakage current is defined as the leakage current flowing into or out of the drain pin when the switch is on. This current is denoted by the symbol $I_{D (ON)}$.

Either the source pin or drain pin is left floating during the measurement. Figure 29 shows the circuit used for measuring the on-leakage current, denoted by $I_{S(ON)}$ or $I_{D(ON)}$.



Figure 29. On-Leakage Measurement Setup

7.4 I_{POFF} Leakage Current

 I_{POFF} leakage current is defined as the leakage current flowing into or out of the source pin when the device is powered off. This current is denoted by the symbol I_{POFF} .

The setup used to measure both I_{POFF} leakage current is shown in Figure 30.



Figure 30. IPOFF Leakage Measurement Setup

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7.5 Transition Time

Transition time is defined as the time taken by the output of the device to rise or fall 10% after the select signal has risen or fallen past the logic threshold. The 10% transition measurement is utilized to provide the timing of the device. The time constant from the load resistance and load capacitance can be added to the transition time to calculate system level timing. Figure 31 shows the setup used to measure transition time, denoted by the symbol t_{TRANSITION}.



Figure 31. Transition-Time Measurement Setup

7.6 t_{ON (EN)} and t_{OFF (EN)} Time

The $t_{ON (EN)}$ time is defined as the time taken by the output of the device to rise to 90% after the enable has fallen past the logic threshold. The 90% measurement is used to provide the timing of the device being enabled in the system. Figure 32 shows the setup used to measure the enable time, denoted by the symbol $t_{ON (EN)}$.

The $t_{OFF (EN)}$ time is defined as the time taken by the output of the device to fall to 90% after the enable has fallen past the logic threshold. The 90% measurement is used to provide the timing of the device being disabled in the system. Figure 32 shows the setup used to measure enable time, denoted by the symbol $t_{OFF (EN)}$.



Figure 32. toN (EN) and toFF (EN) Time Measurement Setup



7.7 $t_{ON (VDD)}$ and $t_{OFF (VDD)}$ Time

The $t_{ON (VDD)}$ time is defined as the time taken by the output of the device to rise to 90% after the supply has risen past the supply threshold. The 90% measurement is used to provide the timing of the device turning on in the system. Figure 33 shows the setup used to measure turn on time, denoted by the symbol $t_{ON (VDD)}$.

the $t_{OFF (VDD)}$ time is defined as the time taken by the output of the device to fall to 90% after the supply has fallen past the supply threshold. The 90% measurement is used to provide the timing of the device turning off in the system. Figure 33 shows the setup used to measure turn off time, denoted by the symbol $t_{OFF (VDD)}$.



Figure 33. t_{ON (VDD)} and t_{OFF (VDD)}Time Measurement Setup

7.8 Break-Before-Make Delay

Break-before-make delay is a safety feature that prevents two inputs from connecting when the device is switching. The output first breaks from the on-state switch before making the connection with the next on-state switch. The time delay between the *break* and the *make* is known as break-before-make delay. Figure 34 shows the setup used to measure break-before-make delay, denoted by the symbol t_{OPEN(BBM)}.



Figure 34. Break-Before-Make Delay Measurement Setup

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7.9 Propagation Delay

Propagation delay is defined as the time taken by the output of the device to rise or fall 50% after the input signal has risen or fallen past the 50% threshold. Figure 35 shows the setup used to measure propagation delay, denoted by the symbol t_{PD} .



Figure 35. Propagation Delay Measurement Setup

7.10 Skew

Skew is defined as the difference between propagation delays of any two outputs of the same device. The skew measurement is taken from the output of one channel rising or falling past 50% to a second channel rising or falling past the 50% threshold when the input signals are switched at the same time. Figure 36 shows the setup used to measure skew, denoted by the symbol t_{SK} .



Figure 36. Skew Measurement Setup



7.11 Charge Injection

The amount of charge injected into the source or drain of the device during the falling or rising edge of the gate signal is known as charge injection, and is denoted by the symbol Q_C . Figure 37 shows the setup used to measure charge injection from source (Sx) to drain (Dx).



Figure 37. Charge-Injection Measurement Setup

7.12 Capacitance

The parasitic capacitance of the device is captured at the source (Sx), drain (Dx), and select (SELx) pins. The capacitance is measured in both the on and off state and is denoted by the symbol C_{ON} and C_{OFF} . Figure 38 shows the setup used to measure capacitance.



Figure 38. Capacitance Measurement Setup

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7.13 Off Isolation

Off isolation is defined as the ratio of the signal at the drain pin (Dx) of the device when a signal is applied to the source pin (Sx) of an off-channel. The characteristic impedance, Z_0 , for the measurement is 50 Ω . Figure 39 shows the setup used to measure off isolation. Use off isolation equation to compute off isolation.





Off Isolation =
$$20 \cdot \text{Log}\left(\frac{V_{\text{OUT}}}{V_{\text{S}}}\right)$$

(1)

7.14 Channel-to-Channel Crosstalk

Crosstalk is defined as the ratio of the signal at the drain pin (Dx) of a different channel, when a signal is applied at the source pin (Sx) of an on-channel. The characteristic impedance, Z_0 , for the measurement is 50 Ω . Figure 40 shows the setup used to measure, and the equation used to compute crosstalk.



Figure 40. Channel-to-Channel Crosstalk Measurement Setup

Channel-to-Channel Crosstalk = $20 \cdot \text{Log}\left(\frac{V_{\text{OUT}}}{V_{\text{S}}}\right)$



7.15 Bandwidth

Bandwidth is defined as the range of frequencies that are attenuated by less than 3 dB when the input is applied to the source pin (Sx) of an on-channel, and the output is measured at the drain pin (Dx) of the device. The characteristic impedance, Z_0 , for the measurement is 50 Ω . Figure 41 shows the setup used to measure bandwidth.





Attenuation = 20 × Log $\left(\frac{V_{OUT}}{V_S}\right)$

(3)

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8 Detailed Description

8.1 Overview

The TMUX1574 is a high speed 2:1 (SPDT) 4-ch. switch with powered-off protection up to 3.6 V. Wide operating supply of 1.5 V to 5.5 V allows for use in a wide array of applications from servers and communication equipment to industrial applications. The device supports bidirectional analog and digital signals on the source (SxA, SxB) and drain (Dx) pins. The wide bandwidth of this switch allows little or no attenuation of high-speed signals at the outputs to pass with minimum edge and phase distortion as well as propagation delay.

The enable (\overline{EN}) pin is an active-low logic pin that controls the connection between the source (SxA, SxB) and drain (Dx) pins of the device. The select pin (SEL) controls the state of all four channels of the TMUX1574 and determines which source pin is connected to the drain. Fail-Safe Logic circuitry allows voltages on the logic control pins to be applied before the supply pin, protecting the device from potential damage. All logic control inputs have 1.8V logic compatible thresholds, ensuring both TTL and CMOS logic compatibility when operating in the valid supply voltage range.

Powered-off protection up to 3.6 V on the signal path of the TMUX1574 provides isolation when the supply voltage is removed ($V_{DD} = 0$ V). Without this protection feature, the system can back-power the supply rail through an internal ESD diode and cause potential damage to the system.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Bidirectional Operation

The TMUX1574 conducts equally well from source (SxA, SxB) to drain (Dx) or from drain (Dx) to source (SxA, SxB). Each channel has very similar characteristics in both directions and supports both analog and digital signals.

8.3.2 Beyond Supply Operation

When the TMUX1574 is powered from 1.5 V to 5.5 V, the valid signal path input/output voltage ranges from GND to V_{DD} x 2, with a maximum input/output voltage of 5.5 V.

Example 1: If the TMUX1574 is powered at 1.5V, the signal range is 0 V to 3 V.

Example 2: If the TMUX1574 is powered at 3V, the signal range is 0 V to 5.5 V.

Example 3: If the TMUX1574 is powered at 5.5V, the signal range is 0 V to 5.5 V.

Other voltage levels not mentioned in the examples support Beyond Supply Operation as long as the supply voltage falls within the recommended operation conditions of 1.5 V to 5.5 V.



Feature Description (continued)

8.3.3 1.8 V Logic Compatible Inputs

The TMUX1574 has 1.8-V logic compatible control inputs. Regardless of the V_{DD} voltage, the control input thresholds remain fixed, allowing a 1.8-V processor GPIO to control the TMUX1574 without the need for an external translator. This saves both space and BOM cost. For more information on 1.8 V logic implementations, refer to *Simplifying Design with 1.8 V logic Muxes and Switches*.

8.3.4 Powered-off Protection

Powered-off protection up to 3.6 V on the signal path of the TMUX1574 provides isolation when the supply voltage is removed ($V_{DD} = 0$ V). When the TMUX1574 is powered-off, the I/Os of the device remain in a high-Z state. Powered-off protection minimizes system complexity by removing the need for power supply sequencing on the signal path. The device performance remains within the leakage performance mentioned in the Electrical Specifications. For more information on powered-off protection, refer to *Eliminate Power Sequencing with Powered-off Protection Signal Switches*.

8.3.5 Fail-Safe Logic

The TMUX1574 has Fail-Safe Logic on the control input pins (SELx) which allows for operation up to 5.5 V, regardless of the state of the supply pin. This feature allows voltages on the control pins to be applied before the supply pin, protecting the device from potential damage. Fail-Safe Logic minimizes system complexity by removing the need for power supply sequencing on the logic control pins. For example, the Fail-Safe Logic feature allows the select pins of the TMUX1574 to be ramped to 5.5 V while $V_{DD} = 0$ V. Additionally, the feature enables operation of the TMUX1574 with $V_{DD} = 1.5$ V while allowing the select pins to interface with a logic level of another device up to 5.5 V.

8.3.6 Low Capacitance

The TMUX1574 has very low capacitance in both the ON and OFF states on the source and drain pins. Low capacitance helps to reduce large overshoots and ringing of an amplifier circuit when the switch is connected to the feedback network. Additionally, low capacitance improves system settling time by reducing the switch time constant formed by the On-resistance and On-capacitance. For more information on the benefits of low capacitance refer to *Improve Stability Issues with Low C_{ON} Multiplexers.*

8.3.7 Integrated Pull-Down Resistors

The TMUX1574 has internal weak pull-down resistors (6 M Ω) to GND to ensure the logic pins are not left floating. This feature integrates up to four external components and reduces system size and cost.



8.4 Device Functional Modes

The enable (\overline{EN}) pin is an active-low logic pin that controls the connection between the source (SxA, SxB) and drain (Dx) pins of the device. When the enable pin is pulled high, all switches are turned off. When the enable is pulled low, the select pin controls the signal path selection. The select pin (SEL) controls the state of all four channels of the TMUX1574 and determines which source pin is connected to the drain pins. When the select pin is pulled low, the SxA pin conducts to the corresponding Dx pins. When the select pin is pulled high, the SxB pin conducts to the corresponding Dx pins. The TMUX1574 logic pins have internal weak pull-down resistors (6 M Ω) to GND so that it powers-on in a known state.

The TMUX1574 can be operated without any external components except for the supply decoupling capacitors. Unused logic control pins should be tied to GND or V_{DD} in order to ensure the device does not consume additional current as highlighted in *Implications of Slow or Floating CMOS Inputs*. Unused signal path inputs (SxA, SxB, or Dx) should be connected to GND.

8.5 Truth Tables

INPUTS		Selected Source Pins Connected To Drain Pins (Dx)						
EN	SEL	Selected Source Fins Connected To Drain Fins (D						
0	0	S1A connected to D1 S2A connected to D2 S3A connected to D3 S4A connected to D4						
0	1	S1B connected to D1 S2B connected to D2 S3B connected to D3 S4B connected to D4						
1	X ⁽¹⁾	Hi-Z (OFF)						

Table 1. TMUX1574 Truth Table

(1) X denotes don't care.



9 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

9.1 Application Information

The TMUX15xx family offers high-speed system performance across a wide operating supply (1.5 V to 5.5 V) and operating temperature (-40°C to +125°C). The TMUX1574 supports a number of features that improve system performance such as 1.8 V logic compatibility, supports input voltages beyond supply, Fail-Safe Logic, and Powered-off Protection up to 3.6 V. These features make the TMUX15xx a family of protection multiplexers and switches that can reduce system complexity, board size, and overall system cost.

9.2 Typical Application

Common applications that require the features of the TMUX1574 include multiplexing various protocols from a possessor or MCU such as SPI, JTAG, or standard GPIO signals. The TMUX1574 provides superior isolation performance when the device is powered. The added benefit of powered-off protection allows a system to minimize complexity by eliminating the need for power sequencing in hot-swap and live insertion applications. The example shown in Figure 42 illustrates the use of the TMUX1574 to multiplex an SPI bus to multiple flash memory devices.



Figure 42. Multiplexing Flash Memory

9.2.1 Design Requirements

For this design example, use the parameters listed in Table 2.

Table	2.	Design	Parameters
-------	----	--------	-------------------

PARAMETERS	VALUES
Supply (V _{DD})	3.3 V
Input / Output signal range	0 V to 3.3 V
Control logic thresholds	1.8 V compatible

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9.2.2 Detailed Design Procedure

The TMUX1574 can be operated without any external components except for the supply decoupling capacitors. The TMUX1574 has internal weak pull-down resistors (6 M Ω) to GND so that it powers-on with the switches in a known state. All inputs signals passing through the switch must fall within the recommend operating conditions of the TMUX1574 including signal range and continuous current. For this design example, with a supply of 3.3 V, the signals can range from 0 V to 3.3 V when the device is powered. This example can also utilize the Powered-off Protection feature and the inputs can range from 0 V to 3.6 V when V_{DD} = 0 V. The max continuous current can be 25 mA. Due to the voltage range and high speed capability, the TMUX1574 example is suitable for use in SPI, JTAG, and I2S applications. Refer to *Enabling SPI-based flash memory expansion by using multiplexers* for more information on using switches and multiplexers for SPI protocol expansion.

9.2.3 Application Curves

Two important specifications when using a switch or multiplexer to pass signals are the device propagation delay and skew.



Figure 43. Propagation Delay and Skew Measurement

10 Power Supply Recommendations

The TMUX1574 operates across a wide supply range of 1.5 V to 5.5 V. Do not exceed the absolute maximum ratings because stresses beyond the listed ratings can cause permanent damage to the devices.

Power-supply bypassing improves noise margin and prevents switching noise propagation from the V_{DD} supply to other components. Good power-supply decoupling is important to achieve optimum performance. For improved supply noise immunity, use a supply decoupling capacitor ranging from 0.1 μ F to 10 μ F from V_{DD} to ground. Place the bypass capacitors as close to the power supply pins of the device as possible using low-impedance connections. TI recommends using multi-layer ceramic chip capacitors (MLCCs) that offer low equivalent series resistance (ESR) and inductance (ESL) characteristics for power-supply decoupling purposes. For very sensitive systems, or for systems in harsh noise environments, avoiding the use of vias for connecting the capacitors to the device pins may offer superior noise immunity. The use of multiple vias in parallel lowers the overall inductance and is beneficial for connections to ground planes.



11.1 Layout Guidelines

When a PCB trace turns a corner at a 90° angle, a reflection can occur. A reflection occurs primarily because of the change of width of the trace. At the apex of the turn, the trace width increases to 1.414 times the width. This increase upsets the transmission-line characteristics, especially the distributed capacitance and self-inductance of the trace which results in the reflection. Not all PCB traces can be straight and therefore some traces must turn corners.Figure 44 shows progressively better techniques of rounding corners. Only the last example (BEST) maintains constant trace width and minimizes reflections.



Figure 44. Trace Example

Route the high-speed signals using a minimum of vias and corners which reduces signal reflections and impedance changes. When a via must be used, increase the clearance size around it to minimize its capacitance. Each via introduces discontinuities in the signal's transmission line and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points, through-hole pins are not recommended at high frequencies.

Do not route high speed signal traces under or near crystals, oscillators, clock signal generators, switching regulators, mounting holes, magnetic devices or ICs that use or duplicate clock signals.

Avoid stubs on the high-speed signals traces because they cause signal reflections.

Route all high-speed signal traces over continuous GND planes, with no interruptions.

Avoid crossing over anti-etch, commonly found with plane splits.

When working with high frequencies, a printed circuit board with at least four layers is recommended; two signal layers separated by a ground and power layer as shown in Figure 45.



Figure 45. Example Layout

The majority of signal traces must run on a single layer, preferably Signal 1. Immediately next to this layer must be the GND plane, which is solid with no cuts. Avoid running signal traces across a split in the ground or power plane. When running across split planes is unavoidable, sufficient decoupling must be used. Minimizing the number of signal vias reduces EMI by reducing inductance at high frequencies.

Figure 46 illustrates an example of a PCB layout with the TMUX1574. Some key considerations are:

Layout Guidelines (continued)

Decouple the V_{DD} pin with a 0.1- μ F capacitor, placed as close to the pin as possible. Make sure that the capacitor voltage rating is sufficient for the V_{DD} supply.

High-speed switches require proper layout and design procedures for optimum performance.

Keep the input lines as short as possible.

Use a solid ground plane to help reduce electromagnetic interference (EMI) noise pickup.

Do not run sensitive analog traces in parallel with digital traces. Avoid crossing digital and analog traces if possible, and only make perpendicular crossings when necessary.

11.2 Layout Example



Figure 46. Example Layout



12 Device and Documentation Support

12.1 Documentation Support

12.1.1 Related Documentation

Texas Instruments, Improve Stability Issues with Low CON Multiplexers.

Texas Instruments, Enabling SPI-based flash memory expansion by using multiplexers.

Texas Instruments, Simplifying Design with 1.8 V logic Muxes and Switches.

Texas Instruments, Eliminate Power Sequencing with Powered-off Protection Signal Switches.

Texas Instruments, System-Level Protection for High-Voltage Analog Multiplexers.

Texas Instruments, *High-Speed Interface Layout Guidelines*.

Texas Instruments, High-Speed Layout Guidelines.

Texas Instruments, QFN/SON PCB Attachment.

Texas Instruments, Quad Flatpack No-Lead Logic Packages.

12.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

12.3 Community Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

12.4 Trademarks

E2E is a trademark of Texas Instruments.

12.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

12.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.



13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



29-Aug-2019

PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	•	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
PTMUX1574DYYR	ACTIVE	SOT-23-THN	DYY	16	3000	TBD	Call TI	Call TI	-40 to 125		Samples
TMUX1574DYYR	PREVIEW	SOT-23-THN	DYY	16	3000	TBD	Call TI	Call TI	-40 to 125		
TMUX1574PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 125	MUX1574	Samples
TMUX1574RSVR	ACTIVE	UQFN	RSV	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAUAG	Level-1-260C-UNLIM	-40 to 125	1574	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

29-Aug-2019

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TMUX1574PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TMUX1574RSVR	UQFN	RSV	16	3000	178.0	13.5	2.1	2.9	0.75	4.0	12.0	Q1

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PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TMUX1574PWR	TSSOP	PW	16	2000	367.0	367.0	35.0
TMUX1574RSVR	UQFN	RSV	16	3000	189.0	185.0	36.0

PW0016A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



PW0016A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PW0016A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

9. Board assembly site may have different recommendations for stencil design.



^{8.} Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

RSV0016A



PACKAGE OUTLINE

UQFN - 0.55 mm max height

ULTRA THIN QUAD FLATPACK - NO LEAD



NOTES:

All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
This drawing is subject to change without notice.



RSV0016A

EXAMPLE BOARD LAYOUT

UQFN - 0.55 mm max height

ULTRA THIN QUAD FLATPACK - NO LEAD



 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



RSV0016A

EXAMPLE STENCIL DESIGN

UQFN - 0.55 mm max height

ULTRA THIN QUAD FLATPACK - NO LEAD



NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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